Search Notes



Application/Control N	lo.

Reexamination 10585832 TESHIROGI ET AL.

Examiner Shih-Chao Chen Art Unit

Applicant(s)/Patent Under

2821

SEARCHED						
Class	Subclass	Date	Examiner			
343	711, 700MS, 895	3/5/09	CHEN			

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST	3/5/09	CHEN		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

/Shih-Chao Chen/ Primary Examiner.Art Unit 2821

U.S. Patent and Trademark Office Part of Paper No.: 20090305